Serial No. 10/042,5_. Filing Date January 9, 2002

Complete Set of Claims

- 1. (Currently Amended) A negative photoresist composition comprising:
 - an alkali soluble polymer consisting essentially of a semprising at least one-unit of structure 1,

$$(CH_2)_n$$
 $Rf_1 \longrightarrow Rf_2$

where Rf₁ and Rf₂ are independently a perfluorinated or partially fluorinated alkyl group; and,

n is 1-8,

- b) a single or mixture of photoacid generators; and,
- c) a crosslinking agent.
- 2. (Delete) The photoresist composition according to claim 1, where the polymer contains other units.
- (Delete) The photoresist composition according to claim 2, where the
 other units are selected from tetrafluoroethylene, ethylene, cycloalkenes,
 substituted cycloalkenes, maleic anhydride, cyanoacrylate and
 cyanomethacrylate.
- 4. (Original) The photoresist composition according to claim 1, where the polymer is poly[5-(2-trifluoromethyl-1,1,1-trifluoro-2-hydroxypropyl)-2-norbornene].

Serial No. 10/042,5...
Filing Date January 9, 2002

- 5. (Original) The photoresist composition according to claim 1, where in the polymer, n is 1.
- 6. (Original) The photoresist composition according to claim 1, further comprising a base.
- 7. (Original) The photoresist composition according to claim 6, where the base is selected from tetrabutylammonium hydroxide, triethanolamine, diethanol amine, trioctylamine, n-octylamine, trimethylsulfonium hydroxide, triphenylsulfonium hydroxide, bis(t-butylphenyl)iodonium cyclamate and tris(tert-butylphenyl)sulfonium cyclamate.
- 8. Original) A process for imaging a negative photoresist comprising the steps of:
 - a) forming on a substrate a photoresist coating from the photoresist composition of claim 1;
 - b) image-wise exposing the photoresist coating;
 - c) postexposure baking the photoresist coating; and
 - developing the photoresist coating with an aqueous alkaline solution.
- 9. (Original) The process of claim 8, where the image-wise exposure wavelength is below 200 nm.
- 10. (Original) The process according to claim 8 where the aqueous alkaline solution comprises tetramethylammonium hydroxide.
- 11. Original) The process according to claim 8 where the aqueous alkaline solution further comprises a surfactant.